

# 128Mb Synchronous DRAM based on 2M x 4Bank x16 I/O

# **Document Title**4Bank x 2M x 16bits Synchronous DRAM

# **Revision History**

Revision No.	History	Draft Date	Remark
0.1	Initial Draft	Jan. 2007	Preliminary
1.0	Final Version	Apr. 2007	
1.1	Correct Typo Error Page10, Page12	July. 2007	
1.2	Correct Typo Error Page 10 : The Note for the Parameter "tOH" ( 2 -> Blank )	Oct. 2007	



#### DESCRIPTION

The Hynix HY57V281620F(L/S)TP series is a 134,217,728bit CMOS Synchronous DRAM, ideally suited for the memory applications which require wide data I/O and high bandwidth. HY57V281620E(L/S)T(P) series is organized as 4banks of  $2,097,152 \times 16$ .

HY57V281620F(L/S)TP is offering fully synchronous operation referenced to a positive edge of the clock. All inputs and outputs are synchronized with the rising edge of the clock input. The data paths are internally pipelined to achieve very high bandwidth. All input and output voltage levels are compatible with LVTTL.

Programmable options include the length of pipeline (Read latency of 2 or 3), the number of consecutive read or write cycles initiated by a single control command (Burst length of 1,2,4,8 or full page), and the burst count sequence(sequential or interleave). A burst of read or write cycles in progress can be terminated by a burst terminate command or can be interrupted and replaced by a new burst read or write command on any cycle. (This pipelined design is not restricted by a '2N' rule)

#### **FEATURES**

- Voltage: VDD, VDDQ 3.3V supply voltage
- All device pins are compatible with LVTTL interface
- 54 Pin TSOPII (Lead Free Package)
- All inputs and outputs referenced to positive edge of system clock
- Data mask function by UDQM, LDQM
- Internal four banks operation
- · Auto refresh and self refresh
- 4096 Refresh cycles / 64ms

- Programmable Burst Length and Burst Type
  - 1, 2, 4, 8 or full page for Sequential Burst
  - 1, 2, 4 or 8 for Interleave Burst
- Programmable CAS Latency; 2, 3 Clocks
- Burst Read Single Write operation
- Operating Temperature
  - Commercial Temperature (0°C to 70°C)
  - Industrial Temperature (-40°C to 85°C)

#### ORDERING INFORMATION

Part No.	<b>Clock Frequency</b>	Organization	Interface	Package
HY57V281620F(L/S)TP-5	200MHz			
HY57V281620F(L/S)TP-6	166MHz	4Banks x 2Mbits x16	IVTTI	54 Pin TSOPII
HY57V281620F(L/S)TP-7	143MHz	TDanks X Ziribits XIO	LVIIL	34 FIII 130FII
HY57V281620F(L/S)TP-H	133MHz			

#### Note:

- 1. HY57V281620FTP Series: Normal power, Lead Free.
- 2. HY57V281620FLTP Series: Low power, Lead Free.
- 3. HY57V281620FLTP Series: Super Low power, Lead Free.
- 4. HY57V281620FST(P) Series: Super Low power; Contact Hynix for availability
- 5. HY57V281620F(L/S)T(P)-x: Commercial Temperature (0°C to 70°C)
- 6. HY57V281620F(L/S)T(P)-xI: Industrial Temperature (-40°C to 85°C)



# **PIN ASSIGNMENTS**

	[				
VDD		$_{1}^{\bigcirc}$	54	Ь	VSS
DQ0		2	53	Ь	DQ15
VDDQ		3	52		VSSQ
DQ1		4	51		DQ14
DQ2		5	50		DQ13
VSSQ		6	49		VDDQ
DQ3		7	48		DQ12
DQ4		8	47	$\vdash$	DQ11
VDDQ		9	46		VSSQ
DQ5		10	45		DQ10
DQ6		11	54 Dia TOODU	$\Box$	DQ9
VSSQ		12	54 Pin TSOPII 43		VDDQ
DQ7		13	400mil x 875mil 42	$\Box$	DQ8
VDD		14	0.8mm pin pitch 41		VSS
LDQM		15	40	Ь	NC
/WE		16	39		UDQM
/CAS		17	38		CLK
/RAS		18	37		CKE
/CS		19	36		NC
BA0		20	35		A11
BA1		21	34		A9
A10/AP		22	33		A8
A0		23	32		A7
A1		24	31	þ	A6
A2		25	30		A5
A3	Ц	26	29	þ	A4
VDD		27	28	þ	VSS

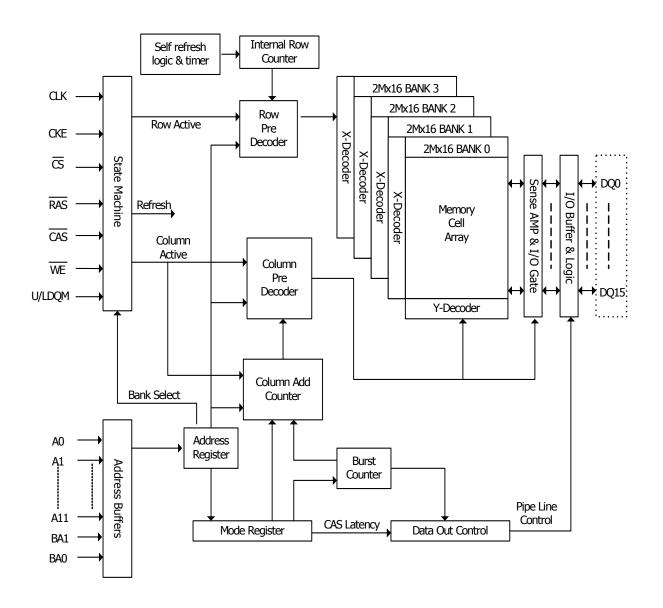


# **PIN DESCRIPTION**

SYMBOL	ТҮРЕ	DESCRIPTION
CLK	Clock	The system clock input. All other inputs are registered to the SDRAM on the rising edge of CLK
CKE	Clock Enable	Controls internal clock signal and when deactivated, the SDRAM will be one of the states among power down, suspend or self refresh
CS	Chip Select	Enables or disables all inputs except CLK, CKE, UDQM and LDQM
BA0, BA1	Bank Address	Selects bank to be activated during RAS activity Selects bank to be read/written during CAS activity
A0 ~ A11	Address	Row Address: RA0 ~ RA11, Column Address: CA0 ~ CA8 Auto-precharge flag: A10
RAS, CAS, WE	Row Address Strobe, Column Address Strobe, Write Enable	RAS, CAS and WE define the operation Refer function truth table for details
UDQM, LDQM	Data Input/Output Mask	Controls output buffers in read mode and masks input data in write mode
DQ0 ~ DQ15	Data Input/Output	Multiplexed data input / output pin
VDD/VSS	Power Supply/Ground	Power supply for internal circuits and input buffers
VDDQ/VSSQ	Data Output Power/Ground	Power supply for output buffers
NC	No Connection	No connection



# **FUNCTIONAL BLOCK DIAGRAM**2Mbit x 4banks x 16 I/O Synchronous DRAM

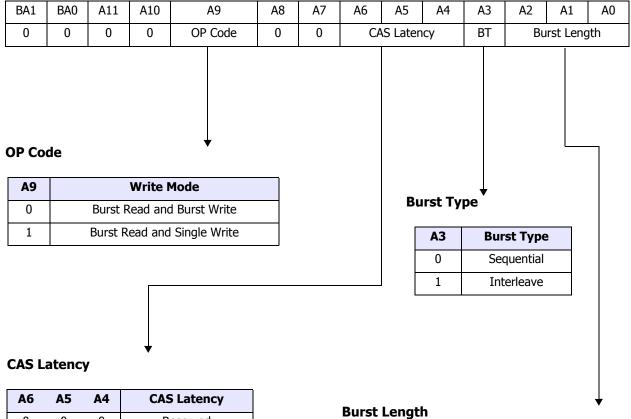


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### **BASIC FUNCTIONAL DESCRIPTION**

#### **Mode Register**



A6	<b>A5</b>	<b>A4</b>	CAS Latency
0	0	0	Reserved
0	0	1	Reserved
0	1	0	2
0	1	1	3
1	0	0	Reserved
1	0	1	Reserved
1	1	0	Reserved
1	1	1	Reserved

A2	A1	AO	Burst I	Length
AZ	ΑI	AU	A3 = 0	A3=1
0	0	0	1	1
0	0	1	2	2
0	1	0	4	4
0	1	1	8	8
1	0	0	Reserved	Reserved
1	0	1	Reserved	Reserved
1	1	0	Reserved	Reserved
1	1	1	Full Page	Reserved



### **ABSOLUTE MAXIMUM RATING**

Parar	Symbol	Rating	Unit		
Ambient Temperature	Commercial Temperature	TA	0 ~ 70	°С	
Ambient Temperature	Industrial Temperature	10	-40 ~ 85	, °C	
Storage Temperature		TSTG	-55 ~ 125	°C	
Voltage on Any Pin relative to VSS		VIN, VOUT	-1.0 ~ 4.6	V	
Voltage on VDD relative to VSS		VDD, VDDQ	-1.0 ~ 4.6	V	
Short Circuit Output Current		IOS	50	mA	
Power Dissipation		PD	1	W	
Soldering Temperature / Time		TSOLDER	260 / 10	°C / Sec	

### **DC OPERATING CONDITION** (Commercial: TA = 0°C to 70°C, Industrial: TA = -40°C to 85°C)

Parameter	Symbol	Min.	Тур	Max	Unit	Note
Power Supply Voltage	VDD, VDDQ	3.0	3.3	3.6	V	1
Input High Voltage	VIH	2.0	3.0	VDDQ + 0.3	V	1, 2
Input Low Voltage	VIL	-0.3	-	0.8	V	1, 3

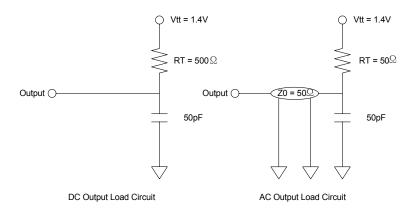
#### Note:

- 1. All voltages are referenced to VSS = 0V
- 2. VIH(max) is acceptable 5.6V AC pulse width with <=3ns of duration.
- 3. VIL(min) is acceptable -2.0V AC pulse width with <=3ns of duration

### **AC OPERATING TEST CONDITION**

(Commercial: TA =  $0^{\circ}$ C to  $70^{\circ}$ C, Industrial: TA =  $-40^{\circ}$ C to  $85^{\circ}$ C, VDD= $3.3\pm0.3$ V, VSS=0V)

Parameter	Symbol	Value	Unit	Note
AC Input High / Low Level Voltage	VIH / VIL	2.4 / 0.4	V	
Input Timing Measurement Reference Level Voltage	Vtrip	1.4	V	
Input Rise / Fall Time	tR / tF	1	ns	
Output Timing Measurement Reference Level Voltage	Voutref	1.4	V	
Output Load Capacitance for Access Time Measurement	CL	50	pF	





### **CAPACITANCE** (Commercial: TA = 0°C to 70°C, Industrial: TA = -40°C to 85°C, f=1MHz, VDD=3.3V)

Parameter	Pin	Symbol	Min	Max	Unit
	CLK	CI1	2.0	4.0	pF
Input capacitance	A0 $\sim$ A11, BA0, BA1, CKE, $\overline{\text{CS}}$ , $\overline{\text{RAS}}$ , $\overline{\text{CAS}}$ , $\overline{\text{WE}}$ , LDQM, UDQM	CI2	2.5	5.0	pF
Data input / output capacitance	DQ0 ~ DQ15	CI/O	3.0	5.5	pF

# **DC CHARACTERISTICS I** (Commercial: TA = 0°C to 70°C, Industrial: TA = -40°C to 85°C)

Parameter	Symbol	Min	Max	Unit	Note
Input Leakage Current	ILI	-1	1	uA	1
Output Leakage Current	ILO	-1	1	uA	2
Output High Voltage	VOH	2.4	-	V	IOH = -2mA
Output Low Voltage	VOL	-	0.4	V	IOL = +2mA

**Note:** 1. VIN = 0 to 3.3V, All other balls are not tested under VIN = 0V

<sup>2.</sup> DOUT is disabled, VOUT=0 to 3.6



# **DC CHARACTERISTICS II** (Commercial: TA = 0°C to 70°C, Industrial: TA = -40°C to 85°C)

Parameter	Symbol Test Condition		ndition	Speed				Unit	Note
raiailletei	Symbol	rest Co	Condition		6	7	Н	Onic	Note
Operating Current	IDD1	Burst length=1, One tRC ≥ tRC(min), IOL		120	110	100	100	mA	1
Precharge Standby Current	IDD2P	CKE ≤ VIL(max), tCk	< = 15ns		:	2	I	mA	
in Power Down Mode	IDD2PS	CKE ≤ VIL(max), tCk	< = ∞		2	2		mA	
Precharge Standby Current in Non Power Down Mode	IDD2N	CKE $\geq$ VIH(min), $\overline{\text{CS}} \geq$ VIH(min), tCK = 15ns Input signals are changed one time during 2clks. All other pins $\geq$ VDD-0.2V or $\leq$ 0.2V		18				mA	
	IDD2NS	$CKE \geq VIH(min) \text{, } tCK = \infty$ Input signals are stable.		15					
Active Standby Current	IDD3P	CKE ≤ VIL(max), tCK = 15ns			5				
in Power Down Mode	IDD3PS	$CKE \le VIL(max)$ , $tCK = \infty$			5				
Active Standby Current in Non Power Down Mode	IDD3N	CKE $\geq$ VIH(min), $\overline{\text{CS}} \geq$ VIH(min), tCK = 15ns Input signals are changed one time during 2clks. All other pins $\geq$ VDD-0.2V or $\leq$ 0.2V						mA	
	IDD3NS	CKE $\geq$ VIH(min), tCK = $\infty$ Input signals are stable.		35					
Burst Mode Operating Current	IDD4	tCK ≥ tCK(min), IOL All banks active	=0mA	120	110	100	100	mA	1
Auto Refresh Current	IDD5	$tRC \ge tRC(min)$ , All I	tRC ≥ tRC(min), All banks active			190	190	mA	2
			Normal	2			mA		
Self Refresh Current	IDD6	CKE ≤ 0.2V	Low power	800			uA	3	
			Super Low Power	500			uA		

#### Note:

- 1. IDD1 and IDD4 depend on output loading and cycle rates. Specified values are measured with the output open
- 2. Min. of tRRC (Refresh  $\overline{RAS}$  cycle time) is shown at AC CHARACTERISTICS II

3. HY57V281620FTP Series: Normal Power HY57V281620FLTP Series: Low Power HY57V281620FSTP Series: Super Low Power

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# $\begin{tabular}{ll} \textbf{AC CHARACTERISTICS I} (AC operating conditions unless otherwise noted) \\ \end{tabular}$

Parameter		Sym-	5		6		7		Н		Unit	Note
		bol	Min	Max	Min	Max	Min	Max	Min	Max		Note
System Clock Cycle Time	CL = 3	tCK3	5.0	1000	6.0	1000	7.0	1000	7.5	100	ns	
System clock Cycle Time	CL = 2	tCK2	10		10	1000	10		10	0	ns	
Clock High Pulse Width		tCHW	1.75	-	2.0	-	2.0	-	2.5	-	ns	1
Clock Low Pulse Width		tCLW	1.75	-	2.0	-	2.0	-	2.5	-	ns	1
Access Time From Clark	CL = 3	tAC3	-	4.5	-	5.4	-	5.4	-	5.4	ns	- 2
Access Time From Clock	CL = 2	tAC2	-	6.0	-	6.0	-	6.0	-	6.0	ns	
Data-out Hold Time		tOH	2.0	-	2.0	-	2.5	-	2.7	-	ns	
Data-Input Setup Time		tDS	1.5	-	1.5	-	1.5	-	1.5	-	ns	1
Data-Input Hold Time		tDH	0.8	-	0.8	-	0.8	-	0.8	-	ns	1
Address Setup Time		tAS	1.5	-	1.5	-	1.5	-	1.5	-	ns	1
Address Hold Time		tAH	0.8	-	0.8	-	0.8	-	0.8	-	ns	1
CKE Setup Time		tCKS	1.5	-	1.5	-	1.5	-	1.5	-	ns	1
CKE Hold Time		tCKH	0.8	-	0.8	-	0.8	-	0.8	-	ns	1
Command Setup Time		tCS	1.5	-	1.5	-	1.5	-	1.5	-	ns	1
Command Hold Time		tCH	0.8	-	0.8	-	0.8	-	0.8	-	ns	1
CLK to Data Output in Low-Z Time		tOLZ	1.0	-	1.0	-	1.5	-	1.5	-	ns	
CLK to Data Output in	CL = 3	tOHZ3	-	4.5	-	5.4	-	5.4	-	5.4	ns	
High-Z Time	CL = 2	tOHZ2	-	6.0	-	6.0	-	6.0	-	6.0	ns	

#### Note:

<sup>1.</sup> Assume tR / tF (input rise and fall time) is 1ns. If tR & tF > 1ns, then [(tR+tF)/2-1]ns should be added to the parameter.

<sup>2.</sup> Access time to be measured with input signals of 1V/ns edge rate, from 0.8V to 2.0V. If tR > 1ns, then (tR/2-0.5)ns should be added to the parameter.



# AC CHARACTERISTICS II (AC operating conditions unless otherwise noted)

Parameter		Symbol	5		6		7		н		Unit	Note
		Syllibol	Min	Max	Min	Max	Min	Max	Min	Max		Note
RAS Cycle Time	Operation	tRC	55	-	60	-	63	-	63	-	ns	
RAS Cycle Time	Auto Refresh	tRRC	55	-	60	-	63	-	63	-	ns	
RAS to CAS Delay		tRCD	15	-	18	-	20	-	20	-	ns	
RAS Active Time		tRAS	38.7	100K	42	100K	42	100K	42	120 K	ns	
RAS Precharge Time		tRP	15	-	18	-	20	-	20	-	ns	
RAS to RAS Bank Active Delay		tRRD	10	-	12	-	14	-	15	-	ns	
CAS to CAS Delay		tCCD	1	-	1	-	1	-	1	-	CLK	
Write Command to Data-In Delay		tWTL	0	-	0	-	0	-	0	-	CLK	
Data-in to Precharge Command		tDPL	2	-	2	-	2	-	2	-	CLK	
Data-In to Active Command		tDAL	tDPL + tRP									
DQM to Data-Out Hi-Z		tDQZ	2	-	2	-	2	-	2	-	CLK	
DQM to Data-In Mask		tDQM	0	-	0	-	0	-	0	-	CLK	
MRS to New Command		tMRD	2	-	2	-	2	-	2	-	CLK	
Precharge to Data Output High-Z	CL = 3	tPROZ3	3	-	3	-	3	-	3	-	CLK	
	CL = 2	tPROZ2	2	-	2	-	2	-	2	-	CLK	
Power Down Exit Time		tDPE	1	-	1	-	1	-	1	-	CLK	
Self Refresh Exit Time		tSRE	1	-	1	-	1	-	1	-	CLK	1
Refresh Time		tREF	-	64	-	64	-	64	-	64	ms	

#### Note:

1. A new command can be given tRRC after self refresh exit.



# **COMMAND TRUTH TABLE**

Comma	nd	CKEn-1	CKEn	cs	RAS	CAS	WE	DQM	ADDR	A10/AP	ВА	Note
Mode Register	Set	Н	Х	L	L	L	L	Х	OP code			
No Operation		Н	Х	Н	Х	Х	Х	Х				
		"	^	L	Н	Н	Н		X			
Bank Active		Н	Х	L	L	Н	Н	Х	RA V		V	
Read		Н	Х	L	Н	L	Н	Х		L	\ \	
Read with Autopre- charge									CA	Н		
Write										L		
Write with charge	Autopre-	Н	X	L	Н	L	L	X	CA	Н	V	
Precharge All Banks		— Н	Х	L	L	Н	L	х	х	Н	Х	
Precharge selected Bank			^						^	L	V	
Burst Stop		Н	Х	L	Н	Н	L	Х				
DQM		Н	X					V				
Auto Refresh		Н	Н	L	L	L	Н	Х	Х			
Burst-Read-Single- WRITE		Н	Х	L	L	L	L	Х	A9 ball High (Other balls OP code)			MRS Mode
Self Refresh	Entry	Н	L	L	L	L	Н	Х				
	Exit	L	Н	Н	Х	Х	Х	Х				
	LAIC	_		L	Н	Н	Н					
Precharge power down	Entry H	Н	L	Н	Х	Х	Х	Х				
	Litery			L	Н	Н	Н		x			
	Exit	L	Н	Н	Х	Х	Х	X				
				L	Н	Н	Н					
Clock Suspend	Entry	Н	L	Н	Х	Х	Х	Х				
		''		L	٧	V	V					
	Exit	L	Н		)	X		Х				



### **PACKAGE INFORMATION**

400mil 54pin Thin Small Outline Package

